Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/590,837	CHYUN, CHAN HYUK	
Examiner	Art Unit	

Kurt Rowan

SEARCHED					
Class	Subclass	Date	Examiner		
43	113	3/6/2008	KR		
	114				
	115				
	116				

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examine	
43	113	3/6/2008	KR	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
A01M 1/04	3/6/2008	KR		